

## **Excellent Integrated System Limited**

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Fairchild Semiconductor FDC6304P

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**Distributor of Fairchild Semiconductor: Excellent Integrated System Limited** Datasheet of FDC6304P - MOSFET 2P-CH 25V 0.46A SSOT-6 Contact us: sales@integrated-circuit.com Website: www.integrated-circuit.com

						July 1997
	6304P					
Digit	al FET, C	Jual P-Channe	el			
Genera	al Descriptio	n		Features		
These P-Channel enhancement mode field effect transistor are produced using Fairchild's proprietary, high cell density, DMOS echnology. This very high density process is tailored to minimize on-state resistance at low gate drive conditions. This device is designed especially for application in battery power applications such as notebook computers and cellular phones. This device has excellent on-state resistance even at gate drive voltages as low as 2.5 volts.			<ul> <li>-25 V, -0.46 A continuous, -1.0 A Peak. R<sub>DS(ON)</sub> = 1.5 Ω @ V<sub>GS</sub> = -2.7 V R<sub>DS(ON)</sub> = 1.1 Ω @ V<sub>GS</sub> = -4.5 V.     </li> <li>Very low level gate drive requirements allowing direct operation in 3V circuits. V<sub>GS(th)</sub> &lt; 1.5 V.</li> <li>Gate-Source Zener for ESD ruggedness. &gt;6kV Human Body Model.     </li> </ul>			
	وش	888 900				
S	OT-23	SuperSOT <sup>™</sup> -6	SuperSOT <sup>™</sup> -8	SO-8	SOT-223	SOIC-16
		Mark: .304 D2 S1 D1		4		3
		D2 S1	G1 G1			- 3
	Su ute Maximu	D1 D1 perSOT™-6	S2			- 2
/mbol	Su ute Maximu Parameter	D1 D1 perSOT <sup>™</sup> -6 um Ratings T <sub>A</sub> =2	S2 G1		FDC6304P	- 2 - 1 - Unit
ymbol DSS	Su ute Maximu Parameter Drain-Source	$D1 \qquad D2 \\ D1 \qquad D1 \qquad D2 \\ D1 \qquad D2 \\ D1 \qquad D2 \\ D2$	S2 G1		FDC6304P -25	- 2 - 1 - 1 - V
ymbol DSS GSS	Su ute Maximu Parameter Drain-Source Gate-Source	$D^{2}$ $D^{1}$ $D^{2}$ $D^{$	S2 G1 25°C unless other wise note		FDC6304P -25 -8	- 2 - 1 - 1 - V - V - V
Absol ymbol DSS GSS	Su ute Maximu Parameter Drain-Source	$D^{2}$ $D^{2$	S2 G1 25°C unless other wise note		FDC6304P -25 -8 -0.46	- 2 - 1 - 1 - V
ymbol DSS GSS	Su ute Maximu Parameter Drain-Source Gate-Source Drain Currer	D2 $D1$ $D1$ $D1$ $D1$ $D2$ $D2$ $D1$ $D2$ $D2$ $D2$ $D2$ $D2$ $D2$ $D2$ $D2$	S2 G1		FDC6304P -25 -8 -0.46 -1	- 2 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1
ymbol DSS GSS	Su ute Maximu Parameter Drain-Source Gate-Source Drain Currer	$D^{2}$ $D^{2$	S2 G1 25°C unless other wise note		FDC6304P -25 -8 -0.46	- 2 - 1 - 1 - V - V - V
ymbol DSS DSS DSS DSS	Su Ute Maximu Parameter Drain-Source Gate-Source Drain Currer Maximum Pe	D2 $D1$ $D1$ $D1$ $D1$ $D2$ $D2$ $D1$ $D2$ $D2$ $D2$ $D2$ $D2$ $D2$ $D2$ $D2$	S2 G1 25°C unless other wise note Jous (Note 1a) (Note 1b)		FDC6304P -25 -8 -0.46 -1 0.9	- 2 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1
ymbol DSS DSS D D J	Su ute Maximu Parameter Drain-Source Gate-Source Drain Currer Maximum Pe Operating ar Electrostatice	$D^{2}$ $D^{$	S2 G1		FDC6304P -25 -8 -0.46 -1 0.9 0.7	- 2 - 1 - 1 - V - V - V - V - V - V - V - V - V - V
ymbol DSS GSS D D J,T <sub>STG</sub> SD	Su ute Maximu Parameter Drain-Source Gate-Source Drain Currer Maximum Pe Operating ar Electrostatice	$D_{A} = 2$ $D_{$	S2 G1		FDC6304P -25 -8 -0.46 -1 0.9 0.7 -55 to 150	- 2 - 1 - 1 - V - V - V - V - A - W
ymbol DSS GSS D D J,T <sub>STG</sub> SD	Su UTE Maximu Parameter Drain-Source Gate-Source Drain Currer Maximum Pa Operating ar Electrostatic Human Bod	$D_{A} = 2$ $D_{$	S2 G1		FDC6304P -25 -8 -0.46 -1 0.9 0.7 -55 to 150	- 2 - 1 - 1 - V - V - V - V - V - V - V - V - V - V



Symbol	Parameter	Conditions	Min	Тур	Max	Units
OFF CHAR	ACTERISTICS					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = -250 \mu A$	-25			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	$I_{\rm D}$ = -250 µA, Referenced to 25 °C		-22		mV /°C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = -20 V, V_{GS} = 0 V$			-1	μA
		T <sub>1</sub> = 55°C			-10	μA
GSS	Gate - Body Leakage Current	$V_{GS} = -8 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
	CTERISTICS (Note 2)		1		1	
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Temp. Coefficient	$I_D = -250 \ \mu$ A, Referenced to $25 \degree$ C		2.1		mV /°0
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.65	-0.86	-1.5	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -2.7 \text{ V}, I_{D} = -0.25 \text{ A}$		1.22	1.5	Ω
()		$V_{GS} = -4.5 \text{ V}, I_{D} = -0.5 \text{ A}$		0.87	1.1	
		T_ =125°C		1.21	2	
D(ON)	On-State Drain Current	$V_{GS} = -2.7 \text{ V}, V_{DS} = -5 \text{ V}$	-0.5			Α
		$V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$	-1			
) <sub>FS</sub>	Forward Transconductance	$V_{DS} = -5 \text{ V}, \text{ I}_{D} = -0.5 \text{ A}$		0.8		S
DYNAMIC C	CHARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		62		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		35		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			9.5		pF
SWITCHING	CHARACTERISTICS (Note 2)					
D(on)	Turn - On Delay Time	$V_{DD} = -6 V, I_{D} = -0.5 A,$		7	20	ns
r	Turn - On Rise Time	$V_{GS}$ = -4.5 V, $R_{GEN}$ = 50 $\Omega$		8	20	ns
D(off)	Turn - Off Delay Time			55	110	ns
f	Turn - Off Fall Time			35	70	ns
ک <sup>6</sup>	Total Gate Charge	$V_{DS} = -5 V, I_{D} = -0.25 A,$ $V_{GS} = -4.5 V$		1.1	1.5	nC
ସ <sub>gs</sub>	Gate-Source Charge	$V_{GS} = -4.5 V$		0.32		nC
ל <sup>מק</sup>	Gate-Drain Charge			0.28		nC
DRAIN-SOU	IRCE DIODE CHARACTERISTICS AND MAX	KIMUM RATINGS				
s	Maximum Continuous Drain-Source Diode Fo	orward Current			-0.5	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = -0.5 A$ (Note 2)	1	-0.88	-1.2	V

a. 140°C/W on a 0.125 in<sup>2</sup> pad of 2oz copper.

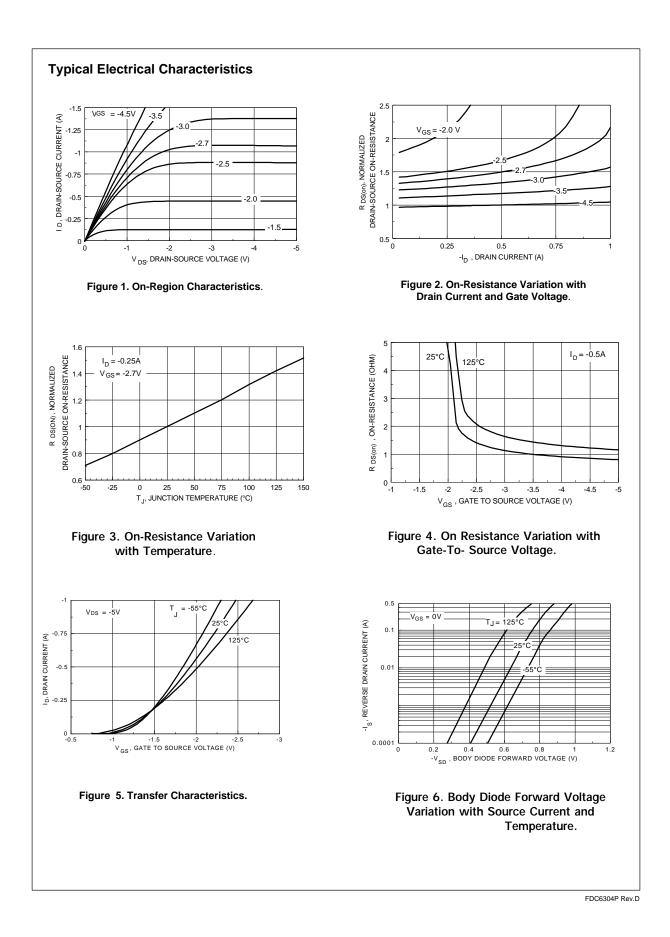
b. 180°C/W on a 0.005 in<sup>2</sup> of pad of 2oz copper.

 $\mathcal{A}$ 

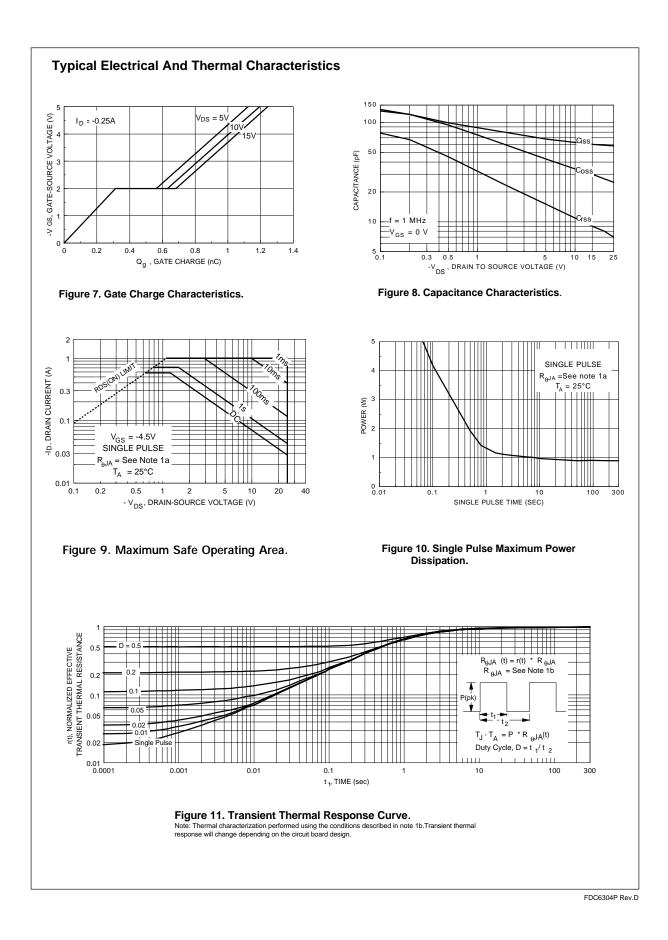
2. Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2.0%.

FDC6304P Rev.D











TRADEMARKS										
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